

International IR Rectifier

PD - 94884

IRF9540PbF

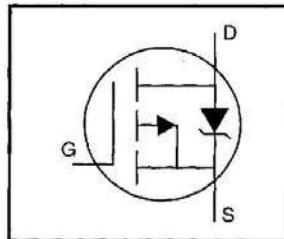
HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175°C Operating Temperature
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead-Free

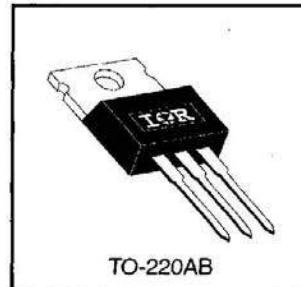
Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



$V_{DSS} = -100V$
$R_{DS(on)} = 0.20\Omega$
$I_D = -19A$



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-19	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10 V$	-13	
I_{DM}	Pulsed Drain Current ①	-72	W
$P_D @ T_C = 25^\circ C$	Power Dissipation	150	
	Linear Derating Factor	1.0	W/°C
V_{GS}	Gate-to-Source Voltage	±20	V
E_{AS}	Single Pulse Avalanche Energy ②	640	mJ
I_{AR}	Avalanche Current ①	-19	A
E_{AR}	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.5	V/ns
T_J	Operating Junction and Storage Temperature Range	-55 to +175	°C
T_{STG}			
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf·in (1.1 N·m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{AJC}	Junction-to-Case	—	—	1.0	°C/W
R_{ACS}	Case-to-Sink, Flat, Greased Surface	—	0.50	—	
R_{AJA}	Junction-to-Ambient	—	—	62	

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-100	—	—	V	$V_{\text{GS}}=0\text{V}$, $I_D=-250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.087	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D=-1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.20	Ω	$V_{\text{GS}}=-10\text{V}$, $I_D=-11\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{\text{DS}}=V_{\text{GS}}$, $I_D=-250\mu\text{A}$
g_{fs}	Forward Transconductance	6.2	—	—	S	$V_{\text{DS}}=-50\text{V}$, $I_D=-11\text{A}$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	-100	μA	$V_{\text{DS}}=-100\text{V}$, $V_{\text{GS}}=0\text{V}$
		—	—	-500	μA	$V_{\text{DS}}=-80\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}}=-20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100	nA	$V_{\text{GS}}=20\text{V}$
Q_g	Total Gate Charge	—	—	61	nC	$I_D=-19\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	14	nC	$V_{\text{DS}}=-80\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	29	nC	$V_{\text{GS}}=-10\text{V}$ See Fig. 6 and 13 ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	16	—	ns	$V_{\text{DD}}=50\text{V}$
t_r	Rise Time	—	73	—	ns	$I_D=-19\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	34	—	ns	$R_G=9.1\Omega$
t_f	Fall Time	—	57	—	ns	$R_D=2.4\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—	nH	
C_{iss}	Input Capacitance	—	1400	—	pF	$V_{\text{GS}}=0\text{V}$
C_{oss}	Output Capacitance	—	590	—	pF	$V_{\text{DS}}=-25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	140	—	pF	$f=1.0\text{MHz}$ See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-19	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-72		
V_{SD}	Diode Forward Voltage	—	—	-5.0	V	$T_J=25^\circ\text{C}$, $I_S=-19\text{A}$, $V_{\text{GS}}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	130	260	ns	$T_J=25^\circ\text{C}$, $I_F=-19\text{A}$
Q_{rr}	Reverse Recovery Charge	—	0.35	0.70	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

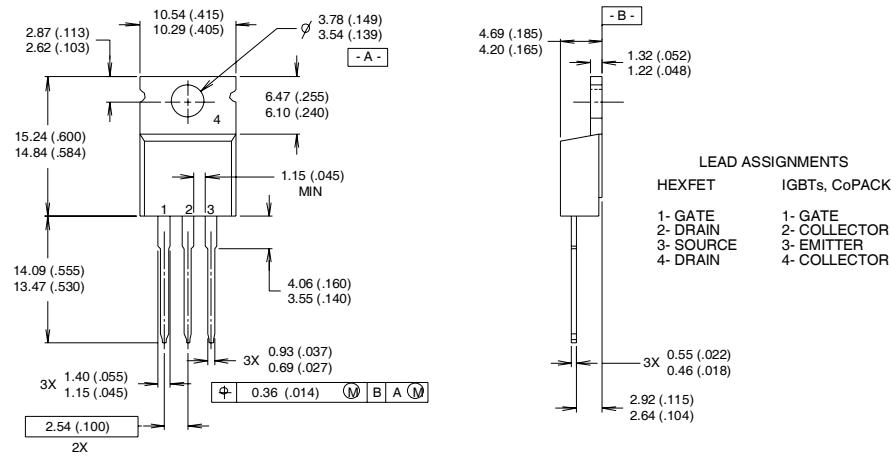
③ $I_{\text{SD}} \leq -19\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$

② $V_{\text{DD}}=-25\text{V}$, starting $T_J=25^\circ\text{C}$, $L=2.7\text{mH}$
 $R_G=25\Omega$, $I_{AS}=-19\text{A}$ (See Figure 12)

④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$.

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.

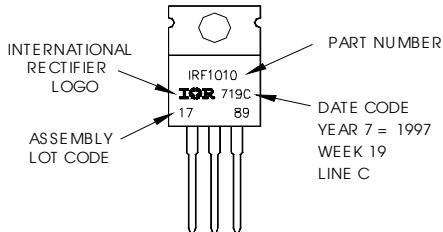
2 CONTROLLING DIMENSION : INCH

3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.

4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"
Note: "P" in assembly line
 position indicates "Lead-Free"



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